



FEATURES

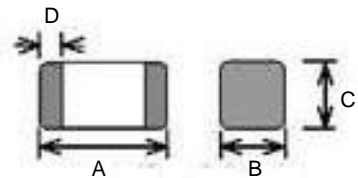
- Internal silver printed layers and magnetic shielded structures to minimize crosstalk
- Monolithic structure for excellent reliability
- Smaller DC resistance and larger allowable current than CVB series
- Can be used in a wide range of frequency to suppress EMI



Shape and Dimensions

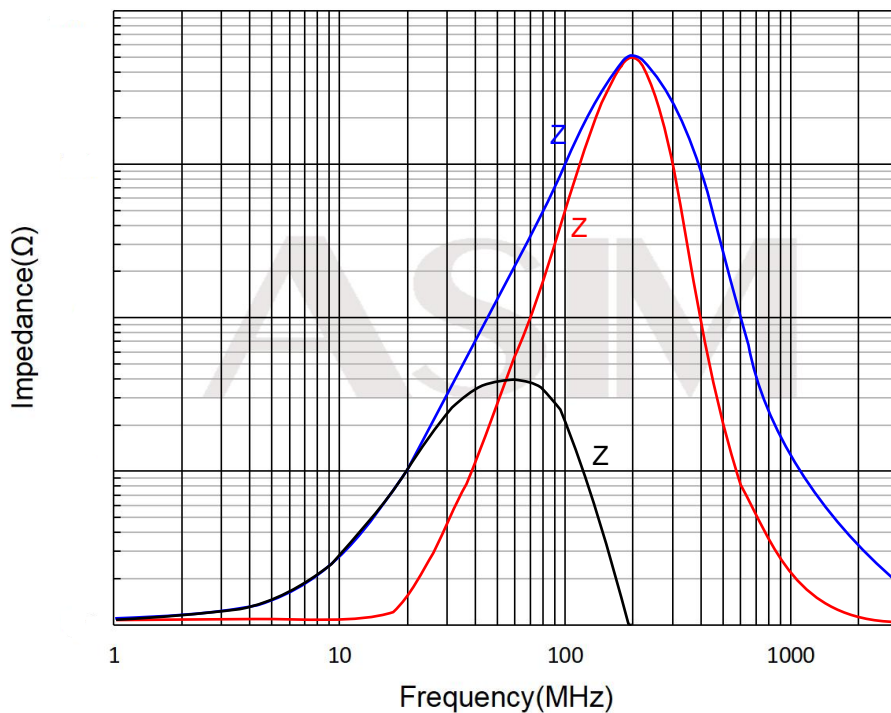
Unit: mm [inch]

Type	A	B	C	D
1005	1.0±0.15	0.5±0.15	0.5±0.15	0.25±0.1
[0402]	[.039±.006]	[.020±.006]	[.020±.006]	[.010±.004]



CVB1005 TYPE

Part Number	Impedance	Z Test Frequency	Max. DC Resistance	Max. Rated Current
Units	Ω	MHz	Ω	mA
Symbol	Z	Freq.	DCR	I _r
CVB1005G601T	600±25%	100	0.34	400





RELIABILITY AND TEST CONDITIONS

Items	Requirements	Test Methods and Remarks																																
1. Operating Temperature Range		-55°C to +125°C																																
2. Storage Temperature Range		-55°C to +125°C																																
3. Terminal Strength	No removal or split of the termination or other defects shall occur.	<ol style="list-style-type: none"> Solder the chip to the testing jig (glass epoxy board shown as the following figure) using eutectic solder. Then apply a force in the direction of the arrow. 2N force for 0603 series. 5N force for 1005 and 1608 series. 10N force for 2010, 2012, 3216, 4516 and 4030 series. Keep time: 10±1s 																																
4. Resistance to Flexure	No visible mechanical damage.	<ol style="list-style-type: none"> Solder the chip to the test jig (glass epoxy board) using a eutectic solder. Then apply a force in the direction shown as the following figure. Flexure: 2mm Pressurizing Speed: 0.5mm/sec Keep time: ≥30 sec <table border="1" style="margin-left: auto; margin-right: auto;"> <thead> <tr> <th>Type</th> <th>a</th> <th>b</th> <th>c</th> </tr> </thead> <tbody> <tr> <td>0603[0201]</td> <td>0.25</td> <td>0.8</td> <td>0.3</td> </tr> <tr> <td>1005[0402]</td> <td>0.4</td> <td>1.5</td> <td>0.5</td> </tr> <tr> <td>1608[0603]</td> <td>1.0</td> <td>3.0</td> <td>1.2</td> </tr> <tr> <td>2012[0805]</td> <td>1.2</td> <td>4.0</td> <td>1.65</td> </tr> <tr> <td>3216[1206]</td> <td>2.2</td> <td>5.0</td> <td>2.0</td> </tr> <tr> <td>4030[1612]</td> <td>1.9</td> <td>6.1</td> <td>3.2</td> </tr> <tr> <td>4516[1806]</td> <td>2.8</td> <td>8.5</td> <td>2.0</td> </tr> </tbody> </table>	Type	a	b	c	0603[0201]	0.25	0.8	0.3	1005[0402]	0.4	1.5	0.5	1608[0603]	1.0	3.0	1.2	2012[0805]	1.2	4.0	1.65	3216[1206]	2.2	5.0	2.0	4030[1612]	1.9	6.1	3.2	4516[1806]	2.8	8.5	2.0
Type	a	b	c																															
0603[0201]	0.25	0.8	0.3																															
1005[0402]	0.4	1.5	0.5																															
1608[0603]	1.0	3.0	1.2																															
2012[0805]	1.2	4.0	1.65																															
3216[1206]	2.2	5.0	2.0																															
4030[1612]	1.9	6.1	3.2																															
4516[1806]	2.8	8.5	2.0																															
5. Vibration	<ol style="list-style-type: none"> No visible mechanical damage. Impedance change: Within ±20%. 	<ol style="list-style-type: none"> Solder the chip to the testing jig (glass epoxy board shown as the following figure) using eutectic solder. The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5 mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours). 																																

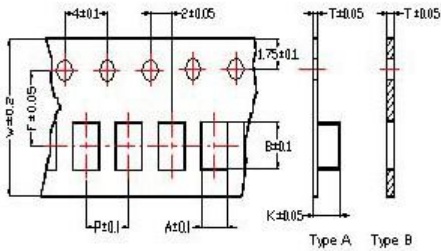


Items	Requirements	Test Methods and Remarks
6. Dropping	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: Within $\pm 20\%$. 	<ul style="list-style-type: none"> ① Drop chip bead 10 times on a concrete floor from a height of 100 cm.
7. Temperature	<ul style="list-style-type: none"> ① Impedance change should be within $\pm 20\%$ of initial value measuring at 20°C. 	<ul style="list-style-type: none"> ① Temperature range: -55°C to $+125^{\circ}\text{C}$ Reference temperature: $+20^{\circ}\text{C}$
8. Solderability	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Wetting shall be exceeded 75% coverage for 0603 series, and 95% coverage for the other. 	<ul style="list-style-type: none"> ① Solder temperature: $240 \pm 2^{\circ}\text{C}$ ② Duration: 3 sec ③ Solder: Sn/3.0Ag/0.5Cu ④ Flux: 25% Resin and 75% ethanol in weight
9. Resistance to Soldering Heat	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Wetting shall be exceeded 75% coverage for 0603 series, and 95% coverage for the other ③ Impedance change: Within $\pm 20\%$. 	<ul style="list-style-type: none"> ① Solder temperature: $260 \pm 3^{\circ}\text{C}$ ② Duration: 5 sec ③ Solder: Sn/3.0Ag/0.5Cu ④ Flux: 25% Resin and 75% ethanol in weight ⑤ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
10. Thermal Shock	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: Within $\pm 20\%$. 	<ul style="list-style-type: none"> ① Temperature and time: -55°C for 30 ± 3 min \rightarrow 125°C for 30 ± 3 min ② Transforming interval: Max. 20 sec ③ Tested cycle: 100 cycles ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring. <p style="text-align: center;"> 125°C Ambient Temperature -55°C 30 min. 30 min. 20sec. (max.) </p>
11. Resistance to Low Temperature	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: Within $\pm 20\%$. 	<ul style="list-style-type: none"> ① Temperature: $-55 \pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
12. Damp Heat (Steady States)	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: Within $\pm 20\%$. 	<ul style="list-style-type: none"> ① Temperature: $60 \pm 2^{\circ}\text{C}$ ② Humidity: 90% to 95% RH ③ Duration: 1000^{+24} hours ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
13. Loading Under Damp Heat	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: Within $\pm 20\%$. 	<ul style="list-style-type: none"> ① Temperature: $60 \pm 2^{\circ}\text{C}$ ② Humidity: 90% to 95% RH ③ Duration: 1000^{+24} hours ④ Applied current: Rated current ⑤ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
14. Loading at High Temperature (Life Test)	<ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: Within $\pm 20\%$. 	<ul style="list-style-type: none"> ① Temperature: $125 \pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours ③ Applied current: Rated current. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.



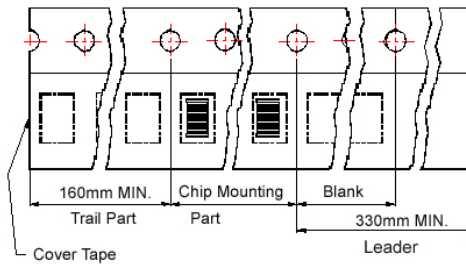
Packaging Specifications

Tape Dimensions

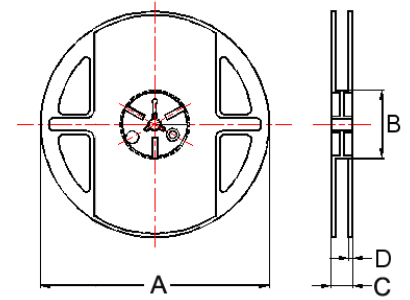


Tape Material

Carrier Tape: Polycarbonate (Tape A)
 Carrier Tape: Paper (Tape B)
 Cover Tape: Polystyrene



Reel Dimensions



Dimensions in mm

TYPE	Tape Dimensions								Reel Dimensions				Quantity
	A	B	T	W	P	F	K	Tape	A	B	C	D	PCS / REEL
1005	0.65	1.15	0.60	8.0	2.0	3.5	-	B	178	60	12	2	10000
1608	1.05	1.85	0.95	8.0	4.0	3.5	-	B	178	60	12	2	4000
2012	1.50	2.30	0.97	8.0	4.0	3.5	-	B	178	60	12	2	4000
3216	1.88	3.50	0.22	8.0	4.0	3.5	1.27	A	178	60	12	2	3000